

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,734,340	03-1988	Saito et al.	428/701
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

	HOIT MENT DOGGLETTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
•	U	Albertinetti et al. "Granularity in ion-beam-sputtered TiO2 films", Applied Optics, Vol. 35, No. 28, 1 October 1996, pp. 5620-5625.					
	v/	Harper et al. "Technology and applications of broad-beam ion sources used in sputtering. Part II. Applications", J. Vac. Sci. Technol., 21(3), sept/Oct 1982 pp. 737-756.					
	w,	/ Mattox "Handbook of Physical Vapor Deposition (PVD) Processing- Film Formation, Adhesion, Surface Preparation and Contamination Control", 1998 pp. 344, 385.					
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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